











TPD12S016

SLLSE96E - SEPTEMBER 2011 - REVISED DECEMBER 2014

TPD12S016 HDMI Companion Chip with I²C Level Shifting Buffer, 12 Channel ESD Protection, and Current-Limit Load Switch

Features

- Conforms to HDMI Compliance Tests without any **External Components**
- IEC 61000-4-2 ESD Protection
 - ±8-kV Contact Discharge
- Supports HDMI 1.4 Data Rate
- Matches Class D and Class C Pin Mapping
- 8-Channel ESD Protection for Four Differential Pairs with Ultra-low Differential Capacitance Matching (0.05 pF)
- On-chip Load Switch with 55-mA Current Limit at the HDMI 5V OUT Pin
- Auto-direction Sensing I²C Level Shifter with Oneshot Circuit to Drive a Long HDMI Cable (750 pF
- Back-drive Protection on HDMI Connector Side **Ports**
- Integrated Pull-up and Pull-down Resistors per **HDMI Specification**
- Space Saving 24-pin RKT Package and 24-TSSOP Package

Applications

- Cell Phones
- eBook
- Portable Media Players
- Set-top Box

3 Description

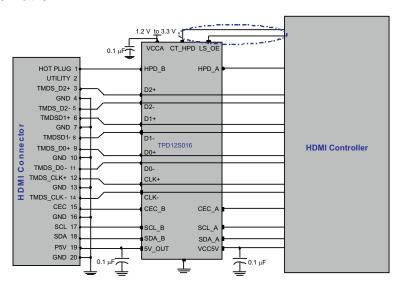
The TPD12S016 is a single-chip High Definition Multimedia Interface (HDMI) device with autodirection sensing I²C voltage level shift buffers, a load switch, and integrated low capacitance high-speed electrostatic discharge (ESD) transient voltage suppression (TVS) protection diodes. A 55-mA current limited 5-V output (5V OUT) sources the HDMI power line. The control of 5V OUT and the hot plug detect (HPD) circuitry is independent of the LS_OE control signal, and is controlled by the CT_HPD pin, which enables the detection scheme (5V_OUT and HPD) to be active before enabling the HDMI link. The SDA, SCL, and CEC lines pull up to V_{CCA} on the A side. On the B side, the CEC_B pin pulls up to an internal 3.3 V supply rail, SCL_B and SDA_B each pull up to the 5-V rail (5V_OUT). The SCL and SDA pins meet the I2C specification and drive up to 750 pF capacitive loads, exceeding the HDMI 1.4 specifications. The HPD B port has a glitch filter to avoid false detection due to plug bouncing during the HDMI connector insertion. TPD12S016 offers reverse current blocking at the 5V_OUT pin. SCL_B, SDA_B, CEC_B pins also feature reversecurrent blocking when the system is powered off.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPD12S016	QFN (24)	4.00 mm × 2.00 mm
170125016	TSSOP (24)	7.80 mm × 6.40 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Simplified Schematic





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5 Revision History

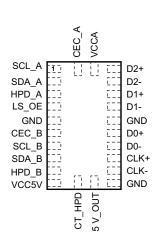
Cł	nanges from Revision D (August 2013) to Revision E	Page
•	Added Handling Rating table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.	1
Cł	nanges from Original (January 2013) to Revision A	Page
•	Added Eye Diagram Using EVM Without TPD12S016 for the TMDS Lines at 1080p, 340MHz Pixel Clock, 3.4Gbps. Added Eye Diagram Using EVM with TPD12S016 for the TMDS Lines at 1080p, 340MHz Pixel Clock, 3.4Gbps	
Cł	nanges from Revision A (February 2013) to Revision B	Page
•	Added PW and RKT packages values for IO capacitance. Added LOAD SWITCH I _{LEAKAGE_REVERSE} vs V _{5V_OUT} graph. Updated Circuit Schematic Diagram.	11
Cł	nanges from Revision B (February 2013) to Revision C	Page
•	Updated table formatting.	6
Cł	nanges from Revision C (August 2013) to Revision D	Page
•	Updated power savings options table	16

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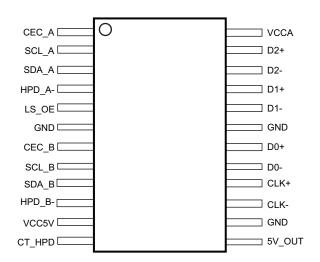
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6 Pin Configuration and Functions



24-RKT Package (Top View) (4.0mm x 2.0mm x 0.5mm)



24-PW Package (Top View) (7.8mm x 6.1mm x 1.2mm)

Pin Functions

MAME	PIN NO.	•	TVDE	DECORIDATION			
NAME	RKT	PW	TYPE	DESCRIPTION			
D-, D+	16, 17, 19-22	17, 18, 20-23	Ю	HDMI TMDS Data. Connect to HDMI Controller and HDMI Connector directly			
CLK+, CLK-	14, 15	15, 16	Ю	HDMI TMDS Clock. Connect to HDMI Controller and HDMI Connector directly			
HPD_A	3	4	0	Hot plug detect Output referenced to V _{CCA} . Connect to HDMI controller Hot plug detect input pin			
HPD_B	9	10	Ι	Hot plug detect Input. Connect directly to HDMI Connector Hot Plug Detect pin			
CEC_A	24	1	Ю	HDMI controller side CEC signal pin referenced to $\ensuremath{V_{\text{CCA}}}.$ Connect to HDMI controller			
CEC_B	6	7	Ю	HDMI connector side CEC signal pin referenced to internal 3.3V supply. Connect to HDMI connector CEC pin			
SCL_A	1	2	Ю	HDMI controller side SCL signal pin referenced to $\ensuremath{\text{V}_{\text{CCA}}}.$ Connect to HDMI controller			
SCL_B	7	8	Ю	HDMI connector side SCL signal pin referenced to 5V_OUT supply. Connect to HDMI connector SCL pin			
SDA_A	2	3	Ю	HDMI controller side SDA signal pin referenced to V_{CCA} . Connect to HDMI controller			
SDA_B	8	9	Ю	HDMI connector side SDA signal pin referenced to 5V_OUT supply. Connect to HDMI connector SDA pin			
LS_OE	4	5	I	Disables the Level shifters when OE =L. The OE pin is referenced to V_{CCA}			
CT_HPD	11	12	I	Disables the load switch and HPD_B when CT_HPD =L. The CT_HPD is referenced to $V_{\rm CCA}$			
V _{CC5V}	10	11	PWR	Internal 5V Supply (Input to the load siwtch)			
V _{CCA}	23	24	PWR	Internal PCB Low Voltage Supply (Same as the HDMI Controller Chip Supply)			
5V_OUT	12	13	0	External 5V Supply (Output of the load switch)			
GND	5, 13, 18	6, 14, 19	GND	Connect to System Ground Plane			

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7 Specifications

7.1 Absolute Maximum Ratings⁽¹⁾⁽²⁾

over operating free-air temperature range (unless otherwise noted)

				VALUE		
			MIN	MAX	UNIT	
V_{CCA}	Supply voltage range		-0.3	4.0	V	
V_{CC5V}	Supply voltage range		-0.3	6.0	V	
VI		SCL_A, SDA_A, CEC_A	-0.3	4.0		
	Input voltage range ⁽²⁾	SCL_B, SDA_B, CEC_B	-0.3	6.0	V	
	input voitage range 💎	CT_HPD, LS_OE	-0.3	4.0	V	
		D, CLK	-0.3	6.0		
	Voltage range applied to any output in	SCL_A, SDA_A, CEC_A, CT_HPD, LS_OE	-0.3	4.0		
Vo	the high-impedance or power-off state (2)	SCL_B, SDA_B, CEC_B	-0.3	6.0	V	
	Voltage range applied to any output in	SCL_A, SDA_A, CEC_A, CT_HPD, LS_OE	-0.3	V _{CCA} + 0.5	V	
Vo	Voltage range applied to any output in the high or low state $^{(2)}$ $^{(3)}$	SCL_B, SDA_B, CEC_B	-0.3	5V_OUT + 0.5	V	
I _{IK}	Input clamp current	VI < 0		-50	mA	
lok	Output clamp current	VO < 0		-50	mA	
	Continuous current through 5V_OUT, or GND			±100	mA	
T _{stg}	Storage temperature range		-65	150	°C	

⁽¹⁾ Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

7.2 ESD Ratings

				VALUE	UNIT	
		Human body model (HBM), per	LS_OE, CT_HPD, SCL_A, SDA_A, CEC_A, HPD_A, V _{CCA}	±2000		
V _(ESD)	Electrostatic	ANSI/ESDA/JEDEC JS-001	Dx, CLKx, SCL_B, SDA_B, CEC_B, HPD_B, 5V_OUT	±15000	V	
(===)	discharge	Charged-device model (CDM), per JED	EC specification JESD22-C101	±1000		
		IEC 61000-4-2 Contact Discharge	Dx, CLKx, SCL_B, SDA_B, CEC_B, HPD_B, 5V_OUT	±8000	V	

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⁽³⁾ The package thermal impedance is calculated in accordance with JESD 51-7.



7.3 Recommended Operating Conditions

over recommended operating free-air temperature range (unless otherwise noted)

				MIN	TYP MAX	UNIT
V _{CCA}	Supply voltage			1.1	3.6	V
V _{CC5V}	Supply voltage			4.5	5.5	V
		SCL_A, SDA_A	V _{CCA} =1.1 V to 3.6 V	0.7 × V _{CCA}	V_{CCA}	V
		CEC_A	V _{CCA} =1.1 V to 3.6 V	0.7 × V _{CCA}	V_{CCA}	V
V	Ulab Javal Sanut valtana	CTHPD, LS_OE	V _{CCA} =1.1 V to 3.6 V	1.0	V_{CCA}	V
V_{IH}	High-level input voltage	SCL_B, SDA_B	5V_OUT = 5.0 V	0.7 × 5V_OUT	5V_OUT	V
		CEC_B	5V_OUT = 5.0 V	$0.7 \times V_{3P3}^{(1)}$	V _{3P3}	
		HPD_B	5V_OUT = 5.0 V	2.0	5V_OUT	
		SCL_A, SDA_A	V _{CCA} =1.1 V to 3.6 V	-0.5	0.082 × V _{CCA}	V
		CEC_A	V _{CCA} =1.1 V to 3.6 V	-0.5	0.082 × V _{CCA}	V
	to the theory	CT_HPD, LS_OE	V _{CCA} =1.1 V to 3.6 V	-0.5	0.4	V
V_{IL}	Low-level input voltage	SCL_B, SDA_B	5V_OUT = 5.0 V	-0.5	0.3 × 5V_OUT	V
		CEC_B	5V_OUT = 5.0 V	-0.5	0.3 × V _{3P3}	V
		HPD_B	5V_OUT = 5.0 V	0	0.8	V
V _{ILC}	(contention) Low-level input voltage	SCL_A, SDA_A, CEC_A	V _{CCA} =1.1 V to 3.6 V	-0.5	0.065 × V _{CCA}	٧
V _{OL} - V _{ILC}	Delta between V_{OL} and V_{ILC}	SCL_A, SDA_A, CEC_A	V _{CCA} =1.1 V to 3.6 V		0.1 x V _{CCA}	mV
T _A	Operating free-air tempera	nture		-40	85	°C

⁽¹⁾ The V_{3P3} is an internal 3.3V power supply node. The V_{3P3} is generated from the 5V supply pin through the on-chip LDO.

7.4 Thermal Information

		TPD1	2S016	
	THERMAL METRIC ⁽¹⁾	RKT	PW	UNIT
		24 PINS	24 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	77.9	88.9	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	24.0	26.5	
$R_{\theta JB}$	Junction-to-board thermal resistance	29.3	43.5	°C/W
ΨЈТ	Junction-to-top characterization parameter	0.5	1.1	
Ψ_{JB}	Junction-to-board characterization parameter	29.3	43.0	

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

Product Folder Links: TPD12S016



7.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER		TE	ST CONDITIONS		MIN	TYP	MAX	UNIT
HIGH SPEE	D ESD LINES: D _X , CL	K _X							
I _{IO}	Current through ES	SD clamp ports	$V_{CCA} = 3.3 \text{ V},$ $V_{CC5V} = 5.0 \text{ V},$ $V_{IO} = 3.3 \text{ V}$	D, CLK			0.01	0.5	μА
V_{DL}	Diode forward volta	age	I _D = 8 mA	Lower clamp d	iode		0.8	1.0	V
R _{DYN}	Dynamic Resistance	ce	I = 1 A	D, CLK			1		Ω
C _{IO}	IO capacitance	PW Package	V _{CC} = 5 V,	D, CLK			1.0		pF
O ₁₀	10 сараспансе	RKT Package	V _{IO} = 2.5 V	D, CER			1.2		рі
ΔC_{IO_TMDS}	Differential capacita Dx- lines	ance for the Dx+,	$V_{CC} = 5 \text{ V},$ $V_{IO} = 2.5 \text{ V}$	D, CLK			0.05		pF
V_{BR}	Break-down Voltag	e	I _{IO} = 1 mA		6.5		9	V	
LOAD SWIT	CH V _{CC5V} , 5V_OUT								
	Supply current at V	CC5V	V _{CC5V} = 5 V, 5V OV CT_HPD = GND	JT =Open, LS_OE	= GND,		1	45	μΑ
I _{CC5V}	Supply current at V	CC5V	V _{CC5V} = 5 V, 5V OV CT_HPD = 3.3 V	JT =Open, LS_OE	= GND,		4	50	μΑ
I _{SC}	Short circuit curren	t at 5V_OUT	V _{CC5V} = 5 V, 5V_O	UT = GND		100	150	200	mA
V_{DROP}	5V_OUT output vo	ltage drop	$V_{CC5V} = 5 \text{ V}, I_{5V_OL}$	_T = 55 mA			35	50	mV
T _{ON}	Turn on Time, V _{CC}	_{5V} to 5V_OUT	$C_{LOAD} = 0.1 \mu F, R_L$	$_{OAD} = 500 \Omega$			77		μs
T _{OFF}	Turn off Time, V _{CC}	_{5V} to 5V_OUT	$C_{LOAD} = 0.1 \mu F, R_L$	$_{OAD}$ = 500 Ω			7.0		μs
T _{SHUT}	Thermal Shutdown		Shutdown threshol	Shutdown threshold, TRIP ⁽¹⁾			140		°C
SHUT	Thermal Shutuown		HYST ⁽²⁾			12			
VOLTAGE L	EVEL SHIFTER - SC	L, SDA LINES (x_A	AND x_B PORTS)						
V_{OHA}			$I_{OH} = -20 \mu A$	$V_{I} = V_{IH}$	V _{CCA} = 1.1 V to 3.6 V	$V_{CCA} \times 0.80$			V
V _{OLA}			I _{OL} = 20 μA	$V_{I} = V_{IL}$	V _{CCA} = 1.1 V to 3.6 V		$V_{CCA} \times 0.17$		V
V_{OHB}			I _{OH} = -20 μA	$V_{I} = V_{IH}$		5VOUT × 0.90			V
V_{OLB}			$I_{OL} = 3 \text{ mA}$	$V_I = V_{IL}$				0.4	V
ΔV_{T}	Hysteresis at the S	$Dx_A (V_{T+} - V_{T-})$	$V_{CCA} = 1.1 \text{ V to } 3.6$	S V			40		mV
ΔV_T	Hysteresis at the S	$Dx_B (V_{T+} - V_{T-})$	$V_{CCA} = 1.1 \text{ V to } 3.6$	S V			400		mV
P	(Internal pull-up)		SCL_A, SDA_A	Pull-up connec	ted to V _{CCA} rail		10		kΩ
R _{PU}	(internal pull-up)		SCL_B, SDA_B	Pull-up connec	ted to 5-V rail		1.75		K\$2
I _{PULLUPAC}	Transient boosted (rise-time accelerate		SCL_B, SDA_B	Pull-up connec	ted to 5-V rail		15		mA
	A port		V _{CCA} = 0 V, V _I or V	O = 0 to 3.6 V	V _{CCA} = 0 V			±5	
l _{off}	B port		5VOUT = 0 V, V _I o	$V_{O} = 0 \text{ to } 5.5 \text{ V}$	V _{CCA} = 0 V to 3.6 V			±5	μA
loz	B port		V _O = V _{CCO} or GND		V _{CCA} = 1.1 V to 3.6 V			±5	μA
l _{OZ}	A port		V _I = V _{CCI} or GND		V _{CCA} = 1.1 V to 3.6 V			±5	μΛ

⁽¹⁾ The TPD12S016 turns off after the device temperature reaches the TRIP temperature.

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⁽²⁾ Once the thermal shut-down circuit turns off the load switch, the switch turns on again after the device junction temperature cools down to a temperature equals to or less than TRIP-HYST.



Electrical Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TES	T CONDITIONS	6	MIN	TYP	MAX	UNIT
VOLTAG	E LEVEL SHIFTER – CEC LINE (x_A AND :	x_B PORTS)						
V _{OHA}		I _{OH} = -20 μA	$V_{I} = V_{IH}$	V _{CCA} = 1.1 V to 3.6 V	V _{CCA} × 0.80			V
V _{OLA}		I _{OL} = 20 μA	$V_{I} = V_{IL}$	V _{CCA} = 1.1 V to 3.6 V		V _{CCA} × 0.17		٧
V_{OHB}		I _{OH} = -20 μA	$V_I = V_{IH}$		$V_{3P3} \times 0.80$			V
V _{OLB}		I _{OL} = 3 mA	$V_I = V_{IL}$				0.4	V
ΔV_T	Hysteresis at the Sxx_A (V _{T+} – V _{T-})	V _{CCA} = 1.1 V to 3.6 V	ĺ			40		mV
ΔV_T	Hysteresis at the Sxx_B (V _{T+} - V _{T-})	V _{CCA} = 1.1 V to 3.6 V	/			300		mV
D	(Internal mull up)	CEC_A	Pull-up conne	cted to V _{CCA} rail		10		1.0
R_{PU}	(Internal pull-up)	CEC_B	Pull-up conne	cted to 3.3 V rail	22	26	30	kΩ
	A port	V _{CCA} = 0 V, V _I or V _O	= 0 to 3.6 V	V _{CCA} = 0 V			±5	
I _{off}	B port	5VOUT = 0 V, V _I or V	$V_{\rm O} = 0 \text{ to } 5.5 \text{ V}$	V _{CCA} = 0 V to 3.6 V			±1.8	μA
	B port	V _O = V _{CCO} or GND		V _{CCA} = 1.1 V to 3.6 V			±5	
l _{OZ}	A port	V _I = V _{CCI} or GND		V _{CCA} = 1.1 V to 3.6 V			±5	μA
VOLTAGI	E LEVEL SHIFTER – HPD LINE (x_A AND	x_B PORTS)						,
V _{OHA}		I _{OH} = −3 mA	$V_{I} = V_{IH}$	V _{CCA} = 1.1 V to 3.6 V	V _{CCA} ×0.07			V
V _{OLA}		I _{OL} = 3 mA	$V_{I} = V_{IL}$	V _{CCA} = 1.1 V to 3.6 V			0.4	V
ΔV_T	Hysteresis (V _{T+} – V _{T-})	V _{CCA} = 1.1 V to 3.6 \	/	'		400		mV
R _{PD}	(Internal pull-down resistor)	HPD_B	Pull-down con	nected to GND		11		kΩ
I _{off}	A port	$V_O = V_{CCO}$ or GND	V _{CCA} = 0 V				±5	μΑ
l _{OZ}	A port	V _I = V _{CCO} or GND	V _{CCA} = 3.6 V				±5	μΑ
LS_OE, C	CT_CP_HPD							,
I _I		$V_I = V_{CCA}$ or GND	V _{CCA} = 1.1 V 1	o 3.6 V			±12	μΑ
I/O CAPA	CITANCES	-						
Cı	Control inputs	V _I = 1.89 V or GND	V _{CCA} = 1.1 V 1	to 3.6 V		7.1		pF
C _{io}	A port	V _O = 1.89 V or GND	V _{CCA} = 1.1 V 1	o 3.6 V		8.3		pF
-10	B port	V _O = 5.0 V or GND	V _{5VOUT} = 5.0 V			15		pF



7.6 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	PINS	TEST CONDITIONS	MIN	TYP	MAX	UNIT
_	Bus Load Capacitance (B Side)					750	_
C_L	Bus Load Capacitance (A Side)					15	pF
VOLTA	AGE LEVEL SHIFTER – SCL, SDA LIN	NES (x_A A	nd x_B PORTS) V _{CCA} = 1.2 V				
		A to B			310		
t _{PHL}	Propagation delay	B to A			420		nS
		A to B			510		
t _{PLH}	Propagation delay	B to A			427		nS
	A Port fall time	A-Port	 		334		
t _{FALL}	B Port fall time	B-Port	SCL/SDA Channels Enabled		225		nS
	A Port rise time	A-Port			315		
t _{RISE}	B Port rise time	B-Port			415		nS
F _(MAX)	Maximum switching frequency		-	400			kHz
	AGE LEVEL SHIFTER - CEC LINES ()	A AND x	B PORTS) V _{CCA} = 1.2 V				
		A to B			385		
t_{PHL}	Propagation delay	B to A	-		526		nS
		A to B	-		13.8		μS
t_{PLH}	Propagation delay	B to A	-		16.6		ηS
	A Port fall time	A-Port	CEC Channel Enabled		334		110
t_{FALL}	B Port fall time	B-Port			170		nS
	A Port rise time	A-Port			315		nS
t _{RISE}		B-Port					
VOLT	B Port rise time		P PORTS) V 4 2 V		20		μS
_	AGE LEVEL SHIFTER - HPD LINES (x		_B FOR 1S) V _{CCA} = 1.2 V		44.4		C
t _{PHL}	Propagation delay	B to A	D A 14.4 9.2 HPD Channel Enabled				μS
t _{PLH}	Propagation delay	B to A			μS		
t _{FALL}	A Port fall time	A-Port	_		2.1		nS
t _{RISE}	A Port rise time	A-Port			2.1		nS
VOLTA	AGE LEVEL SHIFTER – SCL, SDA LIN		ND x_B PORTS) V _{CCA} = 1.5 V				
t _{PHL}	Propagation delay	A to B	-		310		nS
	, ,	B to A	_		420		nS
t _{PLH}	Propagation delay	A to B			410		nS
	1 3	B to A	-		425		nS
t _{FALL}	A Port fall time	A-Port	SCL/SDA Channels Enabled		250		nS
TALL	B Port fall time	B-Port	_		225		nS
t _{RISE}	A Port rise time	A-Port	_		315		nS
KISE	B Port fall time	B-Port			415		nS
$F_{(MAX)}$	Maximum switching frequency			400			kHz
VOLTA	AGE LEVEL SHIFTER – CEC LINES ()	CA AND X	B PORTS) V _{CCA} = 1.5 V				
t	Propagation delay	A to B			380		nS
t _{PHL}	1 Topagation delay	B to A			420		2
+	Propagation dolay	A to B			13.8		μS
t _{PLH}	Propagation delay	B to A	CEC Channel Enabled		16.6		nS
	A Port fall time	A-Port	CEC Channel Enabled		250	-	20
t _{FALL}	B Port fall time	B-Port			170		nS
	A Port rise time	A-Port			315		nS
t _{RISE}	B Port rise time	B-Port]		28		μS

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Switching Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	PINS	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
VOLT	AGE LEVEL SHIFTER – HPD LINES (x	_A AND x	B PORTS) V _{CCA} = 1.5 V					
t _{PHL}	Propagation delay	B to A			14.4		μS	
t _{PLH}	Propagation delay	B to A	HPD Channel Enabled		9.2		μS	
t _{FALL}	A Port fall time	A-Port	- HPD Channel Enabled		1.8		nS	
t _{RISE}	A Port rise time	A-Port				nS		
VOLT	AGE LEVEL SHIFTER – SCL, SDA LIN	IES (x_A A	ND x_B PORTS) V _{CCA} = 1.8 V	1				
_		A to B			300		nS	
t _{PHL}	Propagation delay	B to A			350		nS	
		A to B			400		nS	
t _{PLH}	Propagation delay	B to A			420		nS	
	A Port fall time	A-Port	SCL/SDA Channels Enabled		210		nS	
t _{FALL}	B Port fall time	B-Port			225		nS	
	A Port rise time	A-Port	1		315		nS	
t _{RISE}	B Port fall time	B-Port			415		nS	
F _(MAX)	Maximum switching frequency			400			kHz	
	AGE LEVEL SHIFTER – CEC LINES (x	A AND x	B PORTS) V _{CCA} = 1.8 V					
		A to B	J		375			
t_{PHL}	Propagation delay	B to A			366		nS	
		A to B			13.8		μS	
t_{PLH}	Propagation delay	B to A			16.6		nS	
	A Port fall time	A-Port	CEC Channel Enabled		210		†	
t _{FALL}	B Port fall time	B-Port			170		nS	
	A Port rise time	A-Port			315		nS	
t_{RISE}	B Port rise time	B-Port			28		μS	
VOLT	AGE LEVEL SHIFTER - HPD LINES (x		B PORTS) Voca = 1.8 V					
t _{PHL}	Propagation delay	B to A			14.2		μS	
t _{PLH}	Propagation delay	B to A	-		9.2		μS	
t _{FALL}	A Port fall time	A-Port	HPD ChannelsEnabled		1.5		nS	
t _{RISE}	A Port rise time	A-Port			1.5		nS	
	AGE LEVEL SHIFTER – SCL, SDA LIN		nd x B PORTS) V _{CCA} = 2.5 V		***			
		A to B			300			
t_{PHL}	Propagation delay	B to A	-		400		nS	
		A to B	-		290			
t_{PLH}	Propagation delay	B to A	-		420		nS	
	A Port fall time	A-Port	SCL/SDA Channels Enabled		170			
t_{FALL}		B-Port			225		kHz	
	B Port fall time A Port rise time		-		315		+	
t_{RISE}		A-Port B-Port			415		nS	
-	B Port fall time	ם-רטונ	-	400	400		۲⊔¬	
F _(MAX)	Maximum switching frequency			400			kHz	

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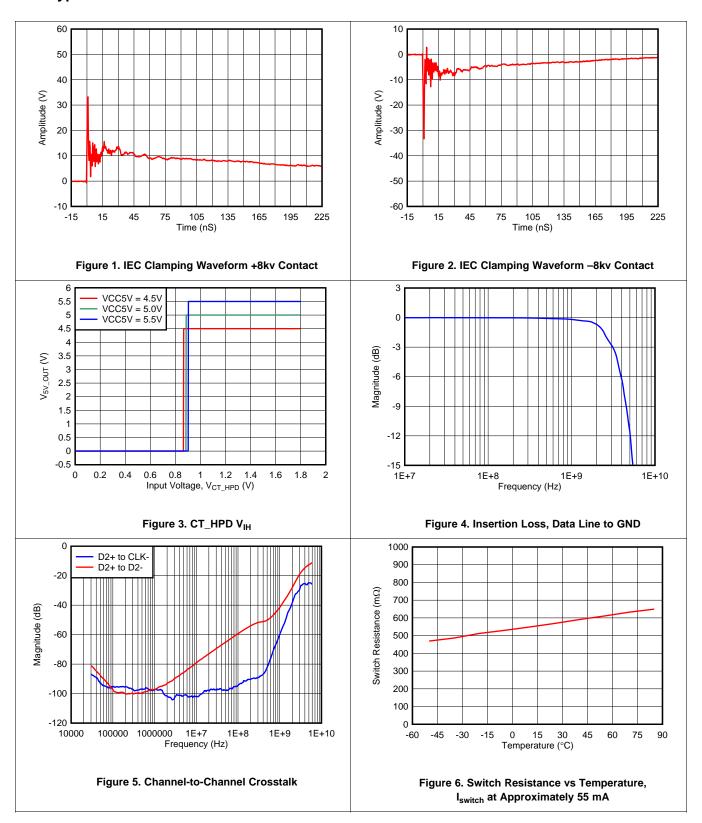
Switching Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	PINS	TEST CONDITIONS	MIN TYP	MAX	UNIT
VOLT	AGE LEVEL SHIFTER – CEC LINES (x	_A AND x	B PORTS) V _{CCA} = 2.5 V			
	Drangation delay	A to B		375		~C
t _{PHL}	Propagation delay	B to A		305		nS
	Description dolors	A to B		13.8		μS
t _{PLH}	Propagation delay	B to A	CEC Channel Freshlad	16.6		nS
	A Port fall time	A-Port	CEC Channel Enabled	170		0
t _{FALL}	B Port fall time	B-Port		170		nS
	A Port rise time	A-Port		315		nS
^T RISE	B Port rise time	B-Port		28		μS
VOLT	AGE LEVEL SHIFTER – HPD LINES (x	_A AND x	B PORTS) V _{CCA} = 2.5 V	1		
t _{PHL}	Propagation delay	B to A		14.2		μS
t _{PLH}	Propagation delay	B to A	LIDD Channel Freshlad	9.2		μS
t _{FALL}	A Port fall time	A-Port	HPD Channel Enabled	1.2		nS
t _{RISE}	A Port rise time	A-Port		1.2		nS
VOLT	AGE LEVEL SHIFTER – SCL, SDA LIN	IES (x_A A	nd x_B PORTS) V _{CCA} = 3.3 V	1		
	Description delect	A to B		300		0
t _{PHL}	Propagation delay	B to A		400		nS
		A to B		260		
t _{PLH}	Propagation delay	B to A	_	415		nS
	A Port fall time	A-Port	SCL/SDA Channels Enabled	160		
t _{FALL}	B Port fall time	B-Port		225		nS
	A Port rise time	A-Port		305		
t _{RISE}	B Port fall time	B-Port		415		nS
F _(MAX)	Maximum switching frequency			400		kHz
. ,	AGE LEVEL SHIFTER – CEC LINES (x	_A AND x	B PORTS) V _{CCA} = 3.3V			
		A to B		375		
t _{PHL}	Propagation delay	B to A		305		nS
	Para and an elabora	A to B		13.8		μS
t _{PLH}	Propagation delay	B to A		16.6		nS
	A Port fall time	A-Port	CEC Channel Enabled	160		
t _{FALL}	B Port fall time	B-Port		170		nS
	A Port rise time	A-Port		305		nS
t _{RISE}	B Port rise time	B-Port		28		μS
VOLT	AGE LEVEL SHIFTER – HPD LINES (x	-	B PORTS) V _{CCA} = 3.3 V	-		
t _{PHL}	Propagation delay	B to A		14.2		μS
t _{PLH}	Propagation delay	B to A	1	9.2		μS
t _{FALL}	A Port fall time	A-Port	HPD Channel Enabled	1.1		nS
t _{RISE}	A Port rise time	A-Port	1	1.1		nS

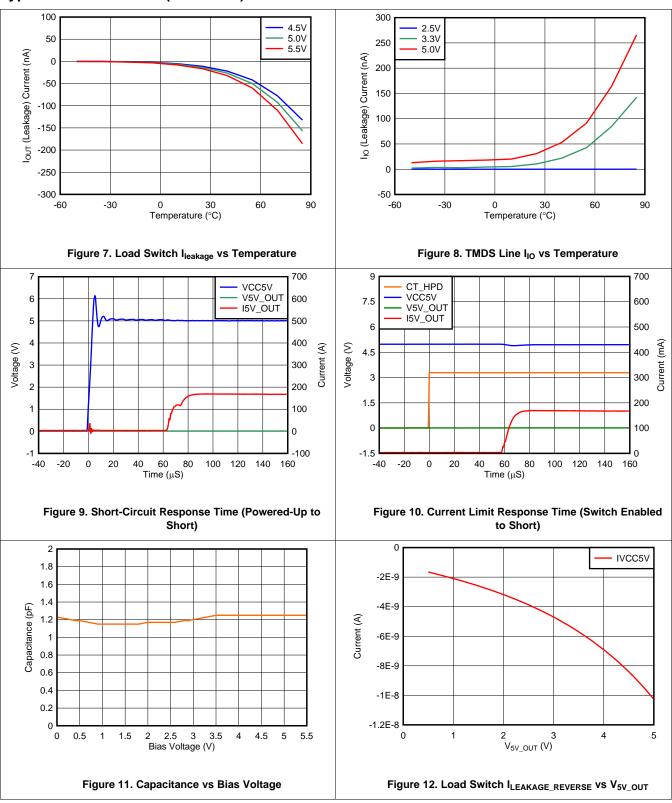


7.7 Typical Characteristics



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Typical Characteristics (continued)



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8 Detailed Description

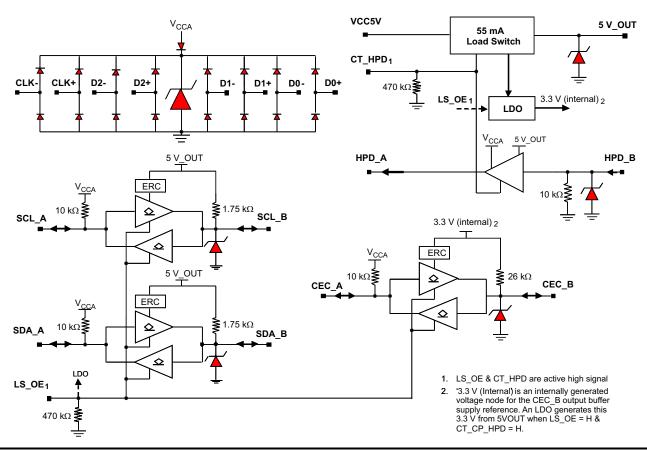
8.1 Overview

The TPD12S016 is a single-chip HDMI interface device with auto-direction sensing I²C voltage level shifting buffers, a load switch, and integrated high-speed ESD protection clamps. The device pin mapping matches the HDMI connector with four differential pairs and control lines. This device offers eight low-capacitance ESD clamps, allowing HDMI 1.4 data rates. The integrated ESD circuits provides matching between each differential signal pair, which allows an advantage over discrete ESD solutions where variations between ESD protection clamps degrade the differential signal quality. The TPD12S016 provides a current limited 5-V output (5V_OUT) for sourcing the HDMI power line. The current limited 5-V output supplies up to 55 mA to the HDMI receiver. The control of 5V_OUT and the hot plug detect (HPD) circuitry is independent of the LS_OE control signal, and is controlled by the CT_HPD pin. This independent CT_HPD control enables the detection scheme (5V_OUT and HPD) to be active before enabling the HDMI link. An internal 3.3 V node powers the CEC pin eliminating the need for a 3.3 V supply on board.

The TPD12S016 integrates all the external termination resistors at the HPD, CEC, SCL, and SDA lines. There are three non-inverting bi-directional voltage level translation (VLT) circuits for the SDA, SCL, and CEC lines. Each have a common power rail (V_{CCA}) on the A side from 1.1 V to 3.6V. On the B side, the SCL_B and SDA_B each have an internal 1.75 k Ω pull up connected to the 5-V rail (5V_OUT). The SCL and SDA pins meet the I²C specification and drive up to 750-pF capacitive loads exceeding the HDMI 1.4 specifications. The CEC_B pin has an internal 27-k Ω pull up resistor to the internal 3.3-V supply rail. The HPD_B port has a glitch filter to avoid false detection due to plug bouncing during the HDMI connector insertion.

The TPD12S016 offers a reverse current blocking feature at the 5V_OUT pin. In the fault conditions, such as when two HDMI transmitters connect to the same HDMI cable, the TPD12S016 ensures that the system is safe from powering up through an external HDMI transmitter. The SCL_B, SDA_B, CEC_B pins also feature reverse-current blocking when the system is powered off.

8.2 Functional Block Diagram



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8.3 Feature Description

8.3.1 Conforms to HDMI Compliance Tests without any External Components

The TPD12S016 has integrated pull-up or pull-down resistors on the DDC, CEC and HPD lines that conform to the HDMI 7.13 and 7.15 Compliance Tests without the designer needing to use any external components to TPD12S016.

8.3.2 IEC 61000-4-2 ESD Protection

In many cases, the core ICs, such as the scalar chipset, may not have robust ESD cells to sustain system-level ESD strikes. In these cases, the TPD12S016 provides the desired system-level ESD protection, such as the IEC 61000-4-2 Level 4 ESD protection of ±8-kV Contact rating by absorbing the energy associated with the ESD strike.

8.3.3 Supports HDMI 1.4 Data Rate

The high-speed TMDS pins of the TPD12S016 add only 1.0-pF (for PW package) or 1.2-pF (for RKT package) of capacitance to the TMDS lines. An Insertion Loss –3 dB point that is greater than 3 GHz provides enough bandwidth to pass HDMI 1.4 TMDS data rates.

8.3.4 Matches Class D and Class C Pin Mapping

The PW and RKT packages offer seamless layout routing options to eliminate the routing glitch for the differential signal pairs. The pin mapping follows the same order as the HDMI connector pin mapping.

8.3.5 8-Channel ESD Lines for Four Differential Pairs with Ultra-low Differential Capacitance Matching (0.05pF)

Excellent intra-pair capacitance matching of 0.05 pF provides ultra low intra-pair skew, which allows an advantage over discrete ESD solutions where variations between ESD protection clamps can degrade the differential signal quality.

8.3.6 On-chip Load Switch with 55mA Current Limit Feature at the HDMI 5V OUT Pin

The TPD12S016 provides a current limited 5-V output (5V_OUT) for sourcing the HDMI power line. The current limited 5-V output supplies up to 55 mA to the HDMI receiver. The control of 5V_OUT and the HPD circuitry is independent of the LS_OE control signal, and is controlled by the CT_HPD pin. This independent CT_HPD control enables the detection scheme (5V OUT and HPD) to be active before enabling the HDMI link.

8.3.7 Auto-direction Sensing I²C Level Shifter with One-shot Circuit to Drive a Long HDMI Cable (750pF Load)

The TPD12S016 contains three bidirectional open-drain buffers specifically designed to support uptranslation/down-translation between the low voltage, V_{CCA} side DDC-bus and the 5-V DDC-bus or 3.3-V CEC line. The HDMI cable side of the DDC lines incorporates rise-time accelerators to support a high capacitive load on the HDMI cable side. The rise time accelerators boost the cable side DDC signal independent of which side of the bus is releasing the signal.

8.3.8 Back-drive Protection on HDMI Connector Side Ports

The TPD12S016 offers a reverse current blocking feature at the 5V_OUT pin. In fault conditions, such as when two HDMI transmitters connect to the same HDMI cable, the TPD12S016 ensures that the system is safe from powering up through an external HDMI transmitter. The SCL_B, SDA_B, CEC_B pins also feature reverse-current blocking when the system is powered off.

8.3.9 Integrated Pull-up and Pull-down Resistors per HDMI Specification

The system is designed to work properly according to the HDMI 1.4 specification with no external pull-up resistors on the DDC, CEC, and HPD lines.

Product Folder Links: TPD12S016



Feature Description (continued)

8.3.10 Space Saving 24-pin RKT Package and 24-TSSOP Package

When compared to discrete ESD solutions, the fully integrated port protection offered by TPD12S016 reduces the overall area required to fully protect an HDMI transmitter port.

8.3.11 DDC/CEC LEVEL SHIFT Circuit Operation

The TPD12S016 enables DDC translation from V_{CCA} (system side) voltage levels to 5-V (HDMI cable side) voltage levels without degradation of system performance. The TPD12S016 contains two bidirectional open-drain buffers specifically designed to support up-translation/down-translation between the low voltage, V_{CCA} side DDCbus and the 5-V DDC-bus. The port B I/Os are over-voltage tolerant to 5.5 V, even when the device is unpowered. After power-up and with the LS_OE and CT_HPD pins HIGH, a LOW level on port A (below approximately V_{ILC} = 0.08 x V_{CCA} V) turns the corresponding port B driver (either SDA or SCL) on and drives port B down to V_{OLB} V. When port A rises above approximately 0.10 × V_{CCA} V, the port B pull-down driver is turned off and the internal pull-up resistor pulls the pin HIGH. When port B falls first and goes below 0.3 x 5 VOUT V, a CMOS hysteresis input buffer detects the falling edge, turns on the port A driver, and pulls port A down to approximately VOLA = 0.16 x V_{CCA} V. The port B pull-down is not enabled unless the port A voltage goes below V_{ILC} . If the port A low voltage goes below V_{ILC} , the port B pull-down driver is enabled until port A rises above $(V_{ILC} + \Delta V_{T-HYSTA})$, then port B, if not externally driven LOW, will continue to rise being pulled up by the internal pull-up resistor.

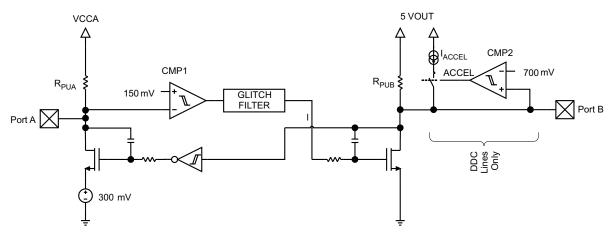


Figure 13. DDC/CEC Level Shifter Block Diagram

8.3.12 DDC/CEC Level Shifter Operational Notes For V_{CCA} = 1.8 V

- The threshold of CMP1 (see Figure 13) is approximately 150 mV ± the 40 mV of total hysteresis.
- The comparator will trip for a falling waveform at approximately 130 mV.
- The comparator will trip for a rising waveform at approximately 170 mV.
- To be recognized as a zero, the level at Port A must first go below 130 mV (V_{ILC} in spec) and then stay below 170 mV (V_{ILA} in spec).

Product Folder Links: TPD12S016

- To be recognized as a one, the level at A must first go above 170 mV and then stay above 130 mV.
- V_{ILC} is set to 117 mV in Electrical Characteristics Table to give some margin to the 130 mV.
- V_{ILA} is set to 148 mV in the *Electrical Characteristics* table to give some margin to the 170 mV.
- V_{IHA} is set to 70% of V_{CCA} to be consistent with standard CMOS levels.

TEXAS INSTRUMENTS

Feature Description (continued)

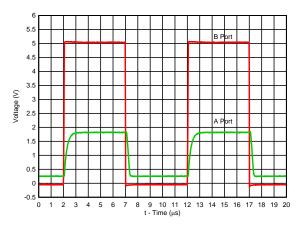


Figure 14. DDC Level Shifter Operation (B To A Direction)

8.3.13 Rise-Time Accelerators

The HDMI cable side of the DDC lines incorporates rise-time accelerators to support high capacitive load (up to 750 pF) on the HDMI cable side. The rise time accelerators boost the cable side DDC signal independent of which side of the bus is releasing the signal.

8.3.14 Noise Considerations

Ground offset between the TPD12S016 ground and the ground of devices on port A of the TPD12S016 must be avoided. The reason for this cautionary remark is that a CMOS/NMOS open-drain capable of sinking 3 mA of current at 0.4 V will have an output resistance of 133 Ω or less (R = E / I). Such a driver will share enough current with the port A output pull-down of the TPD12S016 to be seen as a LOW as long as the ground offset is zero. If the ground offset is greater than 0 V, then the driver resistance must be less. Since V_{ILC} can be as low as 90 mV at cold temperatures and the low end of the current distribution, the maximum ground offset should not exceed 50 mV. Bus repeaters that use an output offset are not interoperable with the port A of the TPD12S016 as their output LOW levels will not be recognized by the TPD12S016 as a LOW. If the TPD12S016 is placed in an application where the V_{IL} of port A of the TPD12S016 does not go below its V_{ILC} it will pull port B LOW initially when port A input transitions LOW but the port B will return HIGH, so it will not reproduce the port A input on port B. Such applications should be avoided. Port B is interoperable with all I²C-bus slaves, masters and repeaters.

8.3.15 Resistor Pull-Up Value Selection

The system is designed to work properly with no external pull-up resistors on the DDC, CEC, and HPD lines.

8.4 Device Functional Modes

The LS_OE and CT_HPD are active-high enable pins. They control the TPD12S016 power saving options according to the following table:

Table 1. Power Saving Options⁽¹⁾

LS_OE	CT_HPD	V _{CCA}	V _{CC5V}	A-side Pull-ups	DDC, B- Side Pull-ups	CEC_B Pull-ups	CEC LDO	Load SW and HPD	DDC/ CEC VLTs	ICCA Typ	ICC5V Typ	Comments
L	L	1.8V	5.0V	Off	Off	Off	Off	Off	Off	1µA	1 μΑ	Fully Disabled
L	Н	1.8V	5.0V	On	On	Off	Off	On	Off	1 µA	30 µA	Load Switch on
Н	L	1.8V	5.0V	Off	Off	Off	Off	Off	Off	1 µA	1 μΑ	Not a Valid State
Н	Н	1.8V	5.0V	On	On	On	On	On	On	13 µA	200 μΑ	Fully On
Х	Х	0V	0V	High-Z	High-Z	High-Z	Off	Off	Off	0	0	Power Down
Х	Х	1.8V	0V	High-Z	High-Z	High-Z	Off	Off	Off	0	0	Power Down
Х	Х	0V	5.0V	High-Z	High-Z	High-Z	Off	Off	Off	0	0	Power Down

(1) X = Don't Care, H = Signal High, and L = Signal Low



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

TPD12S016 provides IEC 61000-4-2 Level 4 Contact ESD rating to the HDMI 1.4 transmitter port. Buffered VLT's translate DDC and CEC channels bi-directionally. The system is designed to work properly with no external pull-up resistors on the DDC, CEC, and HPD lines. The CEC line has an integrated 3.3-V rail, eliminating the need for a 3.3-V supply on board.

9.2 Typical Application

The TPD12S016 is placed as close as possible to the HDMI connector to provide voltage level translation, 5V OUT current limiting and overall ESD protection for the HDMI Controller.

9.2.1 Example 1: HDMI Controller Using One Control Line

In the example shown below, the HDMI Driver Chip is controlling the TPD12S016 via only one control line, CT_HPD. In this mode the HPD_A to LS_OE pin are connected as shown in the oval dotted line of Figure 15. To fully enable TPD12S016, set CT_HPD above V_{IH} . To fully disable TPD12S016, set CT_HPD below V_{II} .

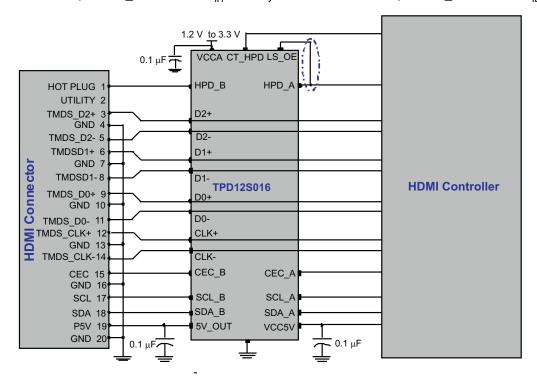


Figure 15. TPD12S016 with an HDMI Controller Using One GPIO for HDMI Interface Control



Typical Application (continued)

9.2.1.1 Design Requirements

For this example, use the following table as input parameters:

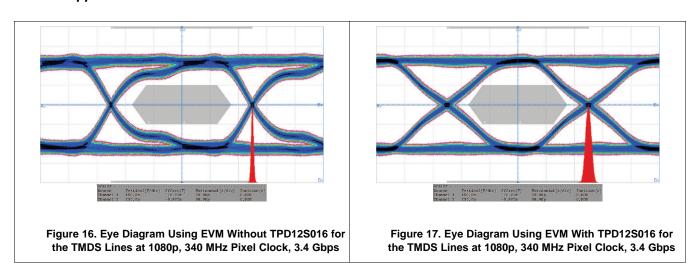
Table 2. HDMI Controller Using One Control Line Design Parameters

		Design Parameters	Example Value
Voltage on V _{CCA}			1.8 V
Voltage on V _{CC5V}			5.0 V
Drive CT_HPD low	(disabled)		-0.5 V - 0.4 V
Drive CT_HPD high	(enabled)		1.0 V – 1.8 V
	A 1 - D	SCL and SDA	4.00 \/ .4.0 \/
Debug a la cia al IIAII	A to B	CEC	1.26 V – 1.8 V
Drive a logical "1"	B to A	SCL and SDA	3.5 V – 5.0 V
		CEC	2.31 V – 3.3 V
	A 1 - D	SCL and SDA	0.5.7. 0.447.7.
Deine - In eine I IIOII	A to B	CEC	-0.5 V – 0.117 V
Drive a logical "0"	D.4- A	SCL and SDA	-0.5 V – 1.5 V
	B to A	CEC	-0.5 V – 0.99 V

9.2.1.2 Detailed Design Procedure

To begin the design process the designer needs to know the V_{CC5V} voltage range and the logic level, V_{CCA} , voltage range.

9.2.1.3 Application Curves





9.2.2 Example 2: HDMI Controller Using CT_HPD and LS_OE

Some HDMI driver chips may have two GPIOs to control the HDMI interface chip. In this case a flexible power saving mode can be implemented. The load switch can be activated by CT_HPD while the level shifters are inactive, using LS_OE. This results in TPD12S016 drawing only approximately 30 μ A, a reduction of 170 μ A from being fully on. After a hot plug is detected, the HDMI controller can enable the rest of the HDMI interface chip using LS_OE.

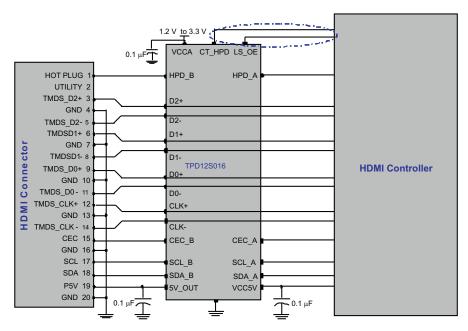


Figure 18. TPD12S016 with an HDMI Controller Using Two GPIOs For HDMI Interface Control

9.2.2.1 Design Requirements

For this example, use the following table as input parameters:

Table 3. HDMI Controller Using CT_HPD and LS_OE Design Parameters

		Design Parameters	Example Value
Voltage on V _{CCA}			3.3 V
Voltage on V _{CC5V}			5.0 V
Drive CT_HPD low	(disabled)		0.5.\/ 0.4.\/
Drive LS_OE low (d	isabled)	-0.5 V – 0.4 V	
Drive CT_HPD high	(enabled)		407/ 007/
Drive LS_OE high (e	enabled)		1.0 V – 3.3 V
	A += D	SCL and SDA	224 // 22 //
Debug a la cia al IIAII	A to B	CEC	2.31 V – 3.3 V
Drive a logical "1"	D. (- A	SCL and SDA	3.5 V – 5.0 V
	B to A	CEC	2.31 V – 3.3 V
	A 1 - D	SCL and SDA	0.5.1/ 0.044.1/
D : 1 : 1 !!!!!	A to B	CEC	-0.5 V – 0.214 V
Drive a logical "0"	D. (- A	SCL and SDA	-0.5 V – 1.5 V
	B to A	CEC	-0.5 V – 0.99 V



9.2.2.2 Detailed Design Procedure

To begin the design process the designer needs to know the V_{CC5V} voltage range and the logic level, V_{CCA} , voltage range.

9.2.2.3 Application Curves

Refer to *Application Curves* for related application curves.

10 Power Supply Requirements

TPD12S016 has two power input pins: V_{CC5V} and V_{CCA} . It can operate normally with V_{CC5V} between 4.5 V and 5.5 V; and V_{CCA} between 1.1 V and 3.6 V. Thus, the power supply (with a ripple of V_{RIPPLE}) requirement for TPD12S016 for V_{CC5V} is between 4.5 V + V_{RIPPLE} and 5.5 V - V_{RIPPLE} ; and for V_{CCA} it is between 1.1 V + V_{RIPPLE} and 3.6 V - V_{RIPPLE} .

11 Layout

11.1 Layout Guidelines

- The optimum placement is as close to the connector as possible.
 - EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures. Therefore, the PCB designer needs to minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.
- · Route the protected traces as straight as possible.
- Avoid using VIAs between the connecter and an I/O protection pin on TPD12S016.
- Avoid 90° turns in traces.
 - Electric fields tend to build up on corners, increasing EMI coupling.
- Minimize impedance on the path to GND for maximum ESD dissipation.
- The capacitors on V_{BUS} and V_{OTG_IN} should be placed close to their respective pins on TPD12S016.

11.2 Layout Example

11.2.1 TPD12S016RKT

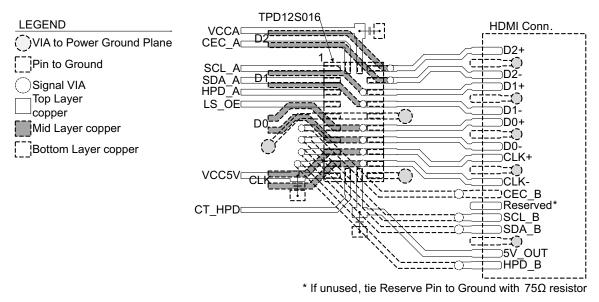


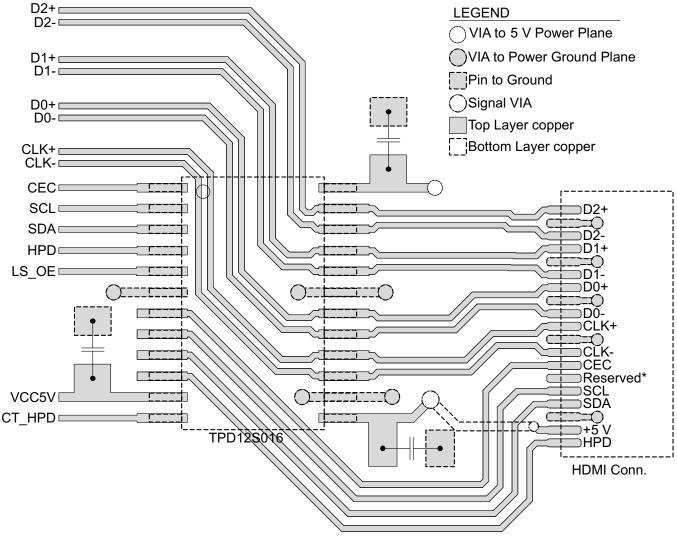
Figure 19. TPD12S016RKT Layout Example



Layout Example (continued)

Routing with TPD12S016RKT requires three layers. VIAs are an integral part of layout for such a design. Proper placement of VIAs can eliminate exposing the system unnecessarily to an ESD event. The example shown above routes the TMDS lines directly from the connector to the protection pins *before* using VIAs to an internal layer. This helps promote ESD energy dissipation at the TPD12S016 protection pins. Note that while there is a VIA between the connector and the DDC/CEC/HPD lines, the traces terminate at the protection pins, leaving no other path for ESD energy to dissipate except at the TPD12S016 protection pins. All ground pins should have a large VIA near them connecting to as many internal and external ground planes as possible to reduce any impedance between TPD12S016 and ground. Tenting of VIAs near to SMD pads should be done to eliminate any solder-wicking during PCB assembly.

11.2.2 TPD12S016PW



* If unused, tie Reserve Pin to Ground with 75Ω resistor

Figure 20. TPD12S016PW Layout Example

The TPD12S016PW can be routed on a single layer. HDMI connector pin matching has been arranged to allow for a flow through routing style. All ground pins should have a large VIA near them connecting to as many internal and external ground planes as possible to reduce any impedance between TPD12S016 and ground. Tenting of VIAs near to SMD pads should be done to eliminate any solder-wicking during PCB assembly.

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12 Device and Documentation Support

12.1 Trademarks

All trademarks are the property of their respective owners.

12.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGE OPTION ADDENDUM

10-Dec-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
TPD12S016PWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PN016	Samples
TPD12S016RKTR	ACTIVE	UQFN	RKT	24	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	PN016	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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n no event shall TI's liabili	tv arising out of such information	exceed the total purchase	price of the TI part(s) at issue in this document sold by	y TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPD12S016PWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1
TPD12S016RKTR	UQFN	RKT	24	3000	177.8	12.4	2.21	4.22	0.81	4.0	12.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPD12S016PWR	TSSOP	PW	24	2000	367.0	367.0	38.0
TPD12S016RKTR	UQFN	RKT	24	3000	202.0	201.0	28.0

PW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



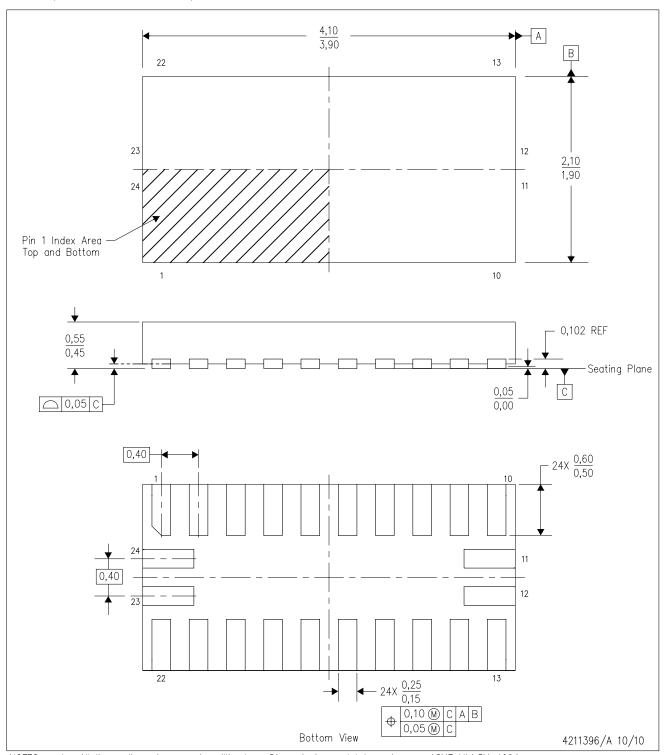
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



RKT (R-PUQFN-N24)

PLASTIC QUAD FLATPACK NO-LEAD



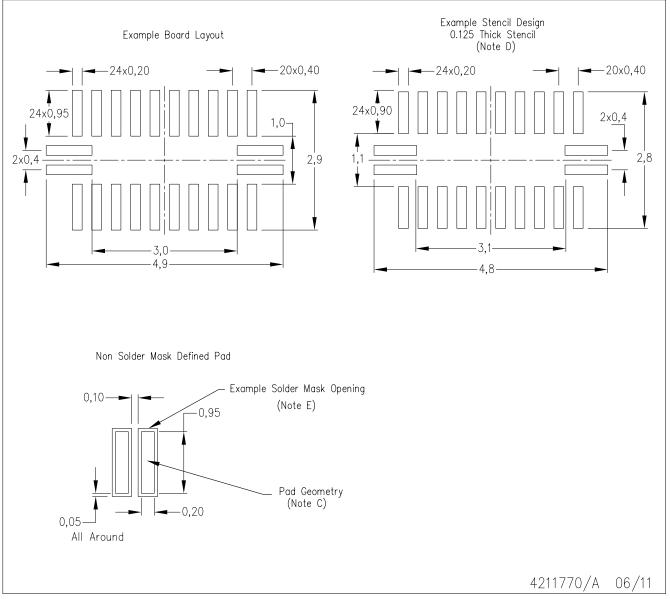
NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.



RKT (R-PUQFN-N24)

PLASTIC QUAD FLATPACK NO-LEAD



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- E. Customers should contact their board fabrication site for recommended solder mask tolerances between and around signal pads



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